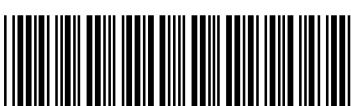


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10760082	ABE ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Shikhman, Max	2609

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	100	3/1/2007	Max Shikhman
382	240	3/7/2007	Max Shikhman

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
IEEE, Google, USPGPUB, USPAT, IBM	3/1/2007	Max Shikhman	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	100	6/1/2008	MS